

MOSFET – Dual, P-Channel (-1.5 V), Specified, POWERTRENCH® –20 V, –0.83 A, 0.5 Ω

FDY1002PZ

General Description

These P-Channel Logic Level MOSFETs are produced using **onsemi**'s advanced POWERTRENCH process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance. These devices are well suited for all applications where small size is desireable but especially low cost DC/DC conversion in battery powered systems.

This Dual P-Channel MOSFET has been designed using **onsemi**'s advanced Power Trench process to optimize the $r_{DS(on)}$ @ $V_{GS} = -1.5 \text{ V}$.

Features

- Max $r_{DS(on)} = 0.5 \Omega$ at $V_{GS} = -4.5 \text{ V}$, $I_D = -0.83 \text{ A}$
- Max $r_{DS(on)} = 0.7 \Omega$ at $V_{GS} = -2.5 \text{ V}$, $I_D = -0.70 \text{ A}$
- Max $r_{DS(on)} = 1.2 \Omega$ at $V_{GS} = -1.8 \text{ V}$, $I_D = -0.43 \text{ A}$
- Max $r_{DS(on)} = 1.8 \Omega$ at $V_{GS} = -1.5 \text{ V}$, $I_D = -0.36 \text{ A}$
- HBM ESD Protection Level = 1400 V (Note 1)
- This Device is Pb-Free and is RoHS Compliant

Application

• Li-Ion Battery Pack

NOTE:

1. The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

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V _{DS}	r _{DS(on)} MAX	I _D MAX
-20 V	0.5 Ω @ -4.5 V	-0.83 A
	0.7 Ω @ -2.5 V	
	1.2 Ω @ -1.8 V	
	1.8 Ω @ –1.5 V	

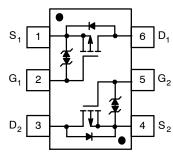


MARKING DIAGRAM



G = Device Code &2 = 2-Digit Date Code

PIN ASSIGNMENT



ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

MOSFET MAXIMUM RATINGS ($T_A = 25^{\circ}C$ unless otherwise noted)

Symbol	Para	Ratings	Unit	
V _{DS}	Drain to Source Voltage		-20	V
V_{GS}	Gate to Source Voltage		±8	V
I _D	Drain Current	- Continuous (Note 2a)	-0.83	Α
		- Pulsed	-1.0	1
P _D	Power Dissipation	(Note 2a)	0.625	W
		(Note 2b)	0.446	1
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 2a)	200	°C/W
$R_{ heta JC}$	Thermal Resistance, Junction to Case (Note 2b)	280	°C/W

2. $R_{\theta JA}$ is determined with the device mounted on a 1 in² oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta JA}$ is determined by the user's board design.



 a. 200°C/W when mounted on a 1 in² pad of 2 oz copper.



b. 280°C/W when mounted on a minimum pad of 2 oz copper.

$\textbf{ELECTRICAL CHARACTERISTICS} \ (T_J = 25^{\circ}\text{C unless otherwise noted})$

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHARA	CTERISTICS					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-20	-	_	V
ΔBV_{DSS}	Breakdown Voltage Temperature Coef-	$I_D = -250 \mu A$, referenced to 25°C	-	-11	-	mV/°C
ΔT_{J}	ficient					
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -16 V, V _{GS} = 0 V	-	-	-1	μΑ
I _{GSS}	Gate to Source Leakage Current	V _{GS} = ±8 V, V _{DS} = 0 V	_	-	±10	μΑ
ON CHARAC	CTERISTICS (Note 3)					
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = -250 \mu A$	-0.4	-0.7	-1.0	V
$\frac{\Delta V_{\rm GS(th)}}{\Delta T_{\rm J}}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = $-250 \mu A$, referenced to $25^{\circ}C$	-	3	-	mV/°C
r _{DS(on)}	Static Drain to Source On-Resistance	$V_{GS} = -4.5 \text{ V}, I_D = -0.83 \text{ A}$	-	0.28	0.5	Ω
		$V_{GS} = -2.5 \text{ V}, I_D = -0.70 \text{ A}$	-	0.36	0.7	
		$V_{GS} = -1.8 \text{ V}, I_D = -0.43 \text{ A}$	-	0.47	1.2	1
		$V_{GS} = -1.5 \text{ V}, I_D = -0.36 \text{ A}$	-	0.62	1.8	
		$V_{GS} = -4.5 \text{ V}, I_D = -0.83 \text{ A}, T_J = 125^{\circ}\text{C}$	-	0.39	0.85	
9FS	Forward Transconductance	V _{DD} = -5 V, I _D = -0.83 A	-	2	-	S
DYNAMIC CI	HARACTERISTICS			-	-	-
C _{iss}	Input Capacitance	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	100	135	pF
C _{oss}	Output Capacitance		-	23	35	pF
C _{rss}	Reverse Transfer Capacitance		_	18	30	pF
SWITCHING	CHARACTERISTICS (Note 3)					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = -10 \text{ V}, I_D = -0.83 \text{ A V}_{GS} = -4.5 \text{ V},$	_	3.5	10	ns
t _r	Rise Time	$R_{GEN} = 6 \Omega$	-	2.9	10	ns
t _{d(off)}	Turn-Off Delay Time		-	23	37	ns
t _f	Fall Time		-	13	23	ns
Qg	Total Gate Charge	$V_{DD} = -10 \text{ V}, I_D = -0.83 \text{ A } V_{GS} = -4.5 \text{ V}$	-	2.2	3.1	nC
Q _{gs}	Gate to Source Charge		-	0.3	_	nC
Q_{gd}	Gate to Drain "Miller" Charge		-	0.6		nC
	RCE DIODE CHARACTERISTICS AND MA	AXIMUM RATING				
I _S	Maximum Continuous Drain-Source Diode Forward Current		-	-	-0.52	Α
V _{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = -0.52 A (Note 3)	-	-1.0	-1.2	V
t _{rr}	Reverse Recovery Time	I _F = -0.83 A, dI _F /dt = 100 A/μs	-	18	31	ns
Q _{rr}	Reverse Recovery Charge		_	3.8	10	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: Pulse Width < 300 µs, Duty Cycle < 2.0%.

TYPICAL ELECTRICAL CHARACTERISTICS

(T_J = 25°C unless otherwise noted)

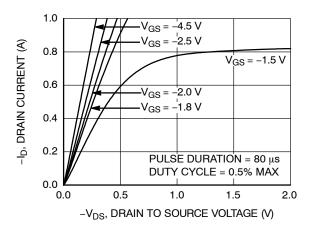


Figure 1. On Region Characteristics

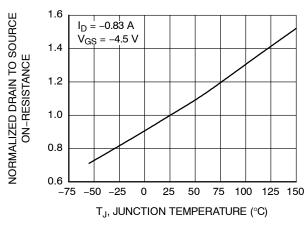


Figure 3. Normalized On Resistance vs. Junction Temperature

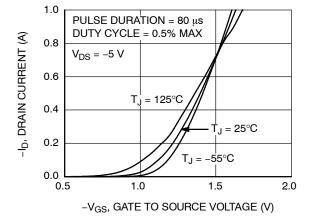


Figure 5. Transfer Characteristics

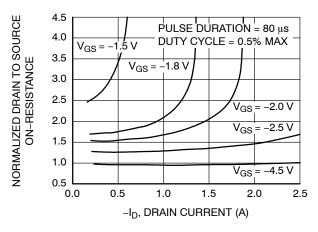


Figure 2. Normalized On–Resistance vs.
Drain Current and Gate Voltage

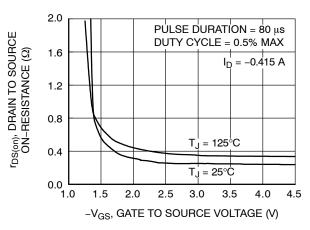


Figure 4. On-Resistance vs. Gate to Source Voltage

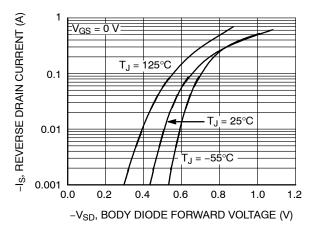


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL ELECTRICAL CHARACTERISTICS

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$ (continued)

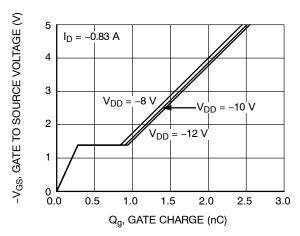


Figure 7. Gate Charge Characteristics

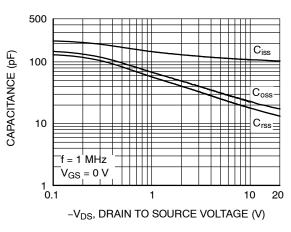


Figure 8. Capacitance vs. Drain to Source Voltage

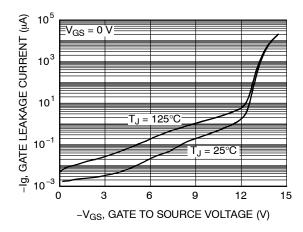


Figure 9. Gate Leakage Current vs. Gate to Source Voltage

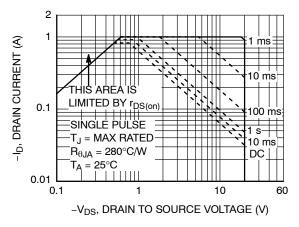


Figure 10. Forward Bias Safe Operating Area

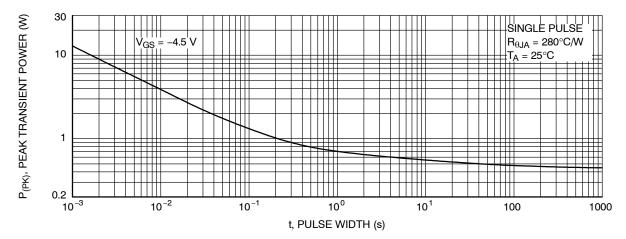


Figure 11. Single Pulse Maximum Power Dissipation

TYPICAL ELECTRICAL CHARACTERISTICS

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$ (continued)

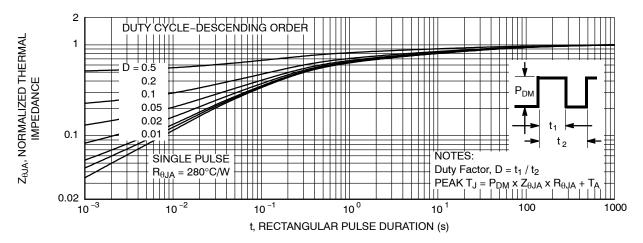


Figure 12. Junction-to-Ambient Transient Thermal Response Curve

PACKAGE MARKING AND ORDERING INFORMATION

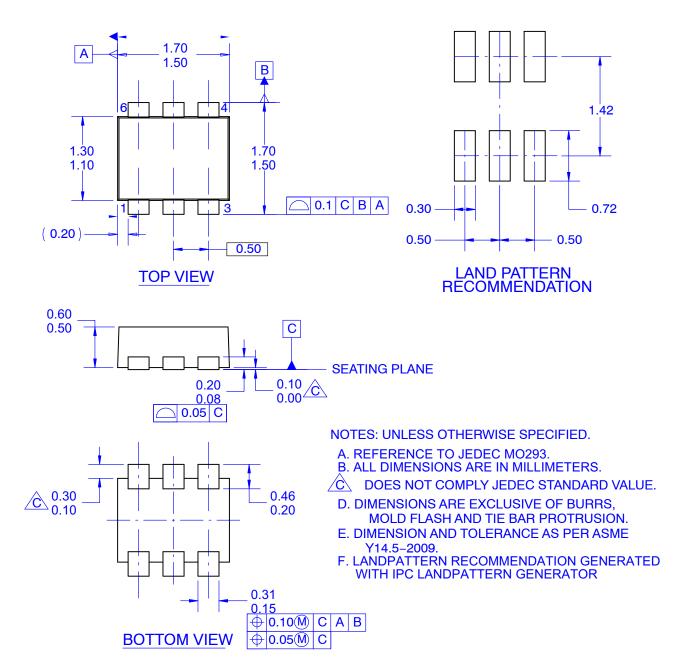
Device	Device Marking	Package	Reel Size	Tape Width	Shipping [†]
FDY1002PZ	G	SOT-563 (Pb-Free)	7"	8 mm	3000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



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DATE 31 AUG 2016



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